

Search Notes

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Examiner

Junghwa M. Im

Applicant(s)/Patent under
Reexamination

BAYAN ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	666,678 669,676	11/11/2004	JMI
257	670,672	11/11/2004	JMI
257	687,701	11/11/2004	JMI
above	updated	12/1/2005	JMI
above	updated	12/1/2005	JMI
above	updated	5/11/2006	JMI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
As	above	5/11/2006	JMI
see search history printout			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (uspat, uspub, epo, jpo, der, ibm)	5/11/2006	JMI